S	ea	rc	h l	No	te.	S	
						1	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/808,620	YALOVSKY ET AL.	
Examiner	Art Unit	
Nam Huynh	2617	

	SEARCHED				
Class	Subclass	Date	Examiner		
455	414.1	1/4/2008	NTH		
	466				
715	531-534	1/4/2008	NTH		
	540				
707	10	1/4/2008	NTH		
345	156	1/4/2008	NTH		
	160				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
Same	As Above	1/4/2008	NTH	
		·		
	:			
L			L	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
See EAST search notes.	1/4/2008	NTH
Interference search conducted.	1/4/2008	NTH
ບໍ່ນ Consulted with Examiner Ke Xiao for 345 search class.	1/2/2008	NTH
Consulted with SPE William Hutton regarding search area and allowable subject matter.	1/2/2008	NTH
		_